

8961726 TEXAS INSTR (OPTO)

62C 36714 D

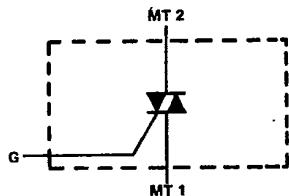
TIC216A, TIC216B, TIC216C, TIC216D,
 TIC216E, TIC216M, TIC216S, TIC216N
 SILICON TRIACS

REVISED OCTOBER 1984

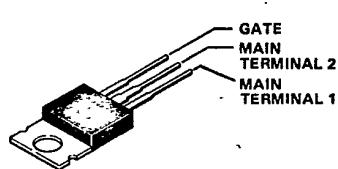
- Sensitive-Gate Triacs
- 100 V to 800 V
- MAX I_{GTO} of 5 mA (Quadrants 1-3)

T-25-15

device schematic



TO-220AB PACKAGE



MAIN TERMINAL 2 IS IN ELECTRICAL CONTACT WITH THE MOUNTING TAB

absolute maximum ratings at 25°C case temperature (unless otherwise noted)

	TIC216A	TIC216B	TIC216C	TIC216D
Repetitive peak off-state voltage, V_{DRM} (see Note 1)	100 V	200 V	300 V	400 V
Full-cycle RMS on-state current at (or below) 70°C case temperature I _T (RMS) (see Note 2)		6 A		
Peak on-state surge current, full sine wave, I _{TSW} (see Note 3)		60 A		
Peak on-state surge current half sine wave, I _{TSW} (see Note 4)		70 A		
Peak gate current, I _{GM}		1 A		
Peak gate power dissipation, P _{GM} , at (or below) 70°C case temperature (pulse duration < 200 μs)		2.2 W		
Average gate power dissipation, P _{G(av)} , at (or below) 70°C case temperature (see Note 5)		0.9 W		
Operating case temperature range		-40°C to 110°C		
Storage temperature range		-40°C to 125°C		
Lead temperature 1.6 mm (1/16 inch) from case for 10 seconds		230°C		

- NOTES:
1. These values apply bidirectionally for any value of resistance between the gate and Main Terminal 1.
 2. This value applies for 50-Hz full sine wave operation with resistive load. Above 70°C derate linearly to 110°C case temperature at the rate of 150 mW/°C.
 3. This value applies for one 50-Hz full sine wave when the device is operating at (or below) the rated value of on-state current. Surge may be repeated after the device has returned to original thermal equilibrium. During the surge, gate control may be lost.
 4. This value applies for one 50-Hz half sine wave when the device is operating at (or below) the rated value of on-state current. Surge may be repeated after the device has returned to original thermal equilibrium. During the surge gate control may be lost.
 5. This value applies for a maximum averaging time of 20 ms.

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B3

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4-25

8961726 TEXAS INSTR (OPTO)

62C 36715 D

T-25-15

TIC216A, TIC216B, TIC216C, TIC216D,
 TIC216E, TIC216M, TIC216S, TIC216N
 SILICON TRIACS

absolute maximum ratings at 25°C case temperature (unless otherwise noted)

	TIC216E	TIC216M	TIC216S	TIC216N
Repetitive peak off-state voltage, V_{DRM} (see Note 1)	500 V	600 V	700 V	800 V
Full-cycle RMS on-state current at (or below) 70°C case temperature, I_{TRMS} (see Note 2)		6 A		
Peak on-state surge current, full sine wave, I_{TSM} (see Note 3)		60 A		
Peak on-state surge current half sine wave, I_{TSM} (see Note 4)		70 A		
Peak gate current, I_{GM}		1 A		
Peak gate power dissipation, P_{GM} , at (or below) 70°C case temperature (pulse duration < 200 μs)		2.2 W		
Average gate power dissipation, $P_{G(av)}$, at (or below) 70°C case temperature (see Note 5)		0.9 W		
Operating case temperature range		-40°C to 110°C		
Storage temperature range		-40°C to 125°C		
Lead temperature 1.6 mm (1/16 inch) from case for 10 seconds		230°C		

- NOTES:
1. These values apply bidirectionally for any value of resistance between the gate and Main Terminal 1.
 2. This value applies for 50-Hz full sine wave operation with resistive load. Above 70°C derate linearly to 110°C case temperature at the rate of 100 mW/°C.
 3. This value applies for one 50-Hz full sine wave when the device is operating at (or below) the rated value of on-state current. Surge may be repeated after the device has returned to original thermal equilibrium. During the surge gate control may be lost.
 4. This value applies for one 50-Hz half sine wave when the device is operating at (or below) the rated value of on-state current. Surge may be repeated after the device has returned to original thermal equilibrium. During the surge gate control may be lost.
 5. This value applies for a maximum averaging time of 20 ms.

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8961726 TEXAS INSTR (OPTO)

62C 36716 D

TIC216A, TIC161B, TIC161C, TIC161D,
 TIC216E, TIC216M, TIC216S, TIC216N
 SILICON TRIACS

electrical characteristics at 25°C case temperature (unless otherwise noted)

T-25-15

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
I _{DRM} Repetitive Peak Off-State Current	V _{DRM} = Rated V _{DRM} , I _G = 0, T _C = 110°C		± 2		mA
I _{GTM} Peak Gate Trigger Current	V _{supply} = + 12 V [†] , R _L = 10 Ω, t _{w(g)} ≥ 20 μs		5		mA
	V _{supply} = + 12 V [†] , R _L = 10 Ω, t _{w(g)} ≥ 20 μs		- 5		
	V _{supply} = - 12 V [†] , R _L = 10 Ω, t _{w(g)} ≥ 20 μs		- 5		
	V _{supply} = - 12 V [†] , R _L = 10 Ω, t _{w(g)} ≥ 20 μs		10		
V _{GTM} Peak Gate Trigger Voltage	V _{supply} = + 12 V [†] , R _L = 10 Ω, t _{w(g)} ≥ 20 μs		2.2		V
	V _{supply} = + 12 V [†] , R _L = 10 Ω, t _{w(g)} ≥ 20 μs		- 2.2		
	V _{supply} = - 12 V [†] , R _L = 10 Ω, t _{w(g)} ≥ 20 μs		- 2.2		
	V _{supply} = - 12 V [†] , R _L = 10 Ω, t _{w(g)} ≥ 20 μs		3		
V _{TM} Peak On-State Voltage	I _{TM} = 8.4 A, I _G = 50 mA, See Note 6		± 1.7		mA
I _H Holding Current	V _{supply} = + 12 V [†] , I _G = 0, Initiating I _{TM} = 100 mA		+ 30		mA
	V _{supply} = - 12 V [†] , I _G = 0, Initiating I _{TM} = - 100 mA		- 30		
I _L Latching Current	V _{supply} = + 12 V [†] , See Note 7		50		mA
	V _{supply} = - 12 V [†] , See Note 7		- 20		
dv/dt	Critical Rate of Rise of Off-State Voltage	V _{DRM} = Rated V _{DRM} , I _G = 0, T _C = 110°C		50	V/μs
dv/dt(c)	Critical Rise of Commutation Voltage	V _{DRM} = Rated V _{DRM} , I _{TRM} = ± 8.4 A, T _C = 70°C		5	V/μs

[†] All voltages are with respect to Main Terminal 1.

- NOTES: 6. These parameters must be measured using pulse techniques, t_w ≤ 1 ms, duty cycle ≤ 2 %. Voltage-sensing contacts, separate from the current-carrying contacts, are located within 3.2 mm (1/8 inch) from the device body.
 7. The triacs are triggered by a 15-V (open-circuit amplitude) pulse supplied by a generator with the following characteristics:
 R_G = 100 Ω, t_w = 20 μs, t_r < 15 ns, t_f ≤ 15 ns, f = 1 kHz.

thermal characteristics

PARAMETER	MIN	TYP	MAX	UNIT
R _{θJC}		2.5		°C/W
R _{θJA}		62.5		

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